

TM09P02AF3

P-Channel Enhancement Mosfet

General Description

- Low $R_{DS(ON)}$
- RoHS and Halogen-Free Compliant

Applications

- Load switch
- PWM

General Features

$V_{DS} = -18\text{ V}$ $I_D = -9.0\text{ A}$

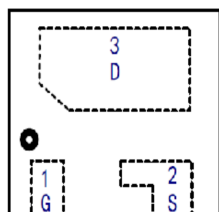
$R_{DS(ON)} = 16\text{ m}\Omega(\text{typ.}) @ V_{GS} = -4.5\text{ V}$

100% UIS Tested

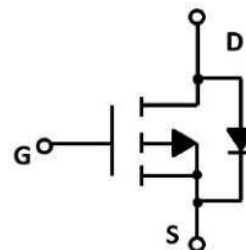
100% R_g Tested



AF3:DFN1.5x1.5-3L



Marking: 09P02



Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter		Max.	Units
V_{DSS}	Drain-Source Voltage		-18	V
V_{GSS}	Gate-Source Voltage		± 12	V
I_D	Continuous Drain Current	$T_A = 25^\circ\text{C}$	-9	A
		$T_A = 100^\circ\text{C}$	-5.8	A
I_{DM}	Pulsed Drain Current ^{note1}		-33	A
P_D	Power Dissipation	$T_A = 25^\circ\text{C}$	2.3	W
$R_{\theta JA}$	Thermal Resistance, Junction to Case		70	$^\circ\text{C/W}$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$

**Electrical Characteristics** ($T_J=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D = -250μA		-18	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -15V, V _{GS} =0V,	-	-	-1	μA
I _{GSS}	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±12V	-	-	±100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D = -250μA	-0.4	-0.7	-1.0	V
R _{DS(on)}	Static Drain-Source on-Resistance note2	V _{GS} = -4.5V, I _D = -7A	-	16	20	mΩ
		V _{GS} = -2.5V, I _D = -5A	-	21	25	
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = -10V, V _{GS} =0V, f=1.0MHz	-	1800	-	pF
C _{oss}	Output Capacitance		-	242	-	pF
C _{rss}	Reverse Transfer Capacitance		-	231	-	pF
Q _g	Total Gate Charge	V _{DS} = -10V, I _D = -3A, V _{GS} = -4.5V	-	15.3	-	nC
Q _{gs}	Gate-Source Charge		-	2.2	-	nC
Q _{gd}	Gate-Drain(“Miller”) Charge		-	4.4	-	nC
Switching Characteristics						
t _{d(on)}	Turn-on Delay Time	V _{DD} = -10V, I _D = -7A, V _{GS} = -4.5V, R _{GEN} =2.5Ω	-	10	-	ns
t _r	Turn-on Rise Time		-	31	-	ns
t _{d(off)}	Turn-off Delay Time		-	28	-	ns
t _f	Turn-off Fall Time		-	8	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	-9	A
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-33	A
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} =0V, I _S = -7A	-	-0.8	-1.2	V

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



Typical Performance Characteristics

Figure 1: Output Characteristics

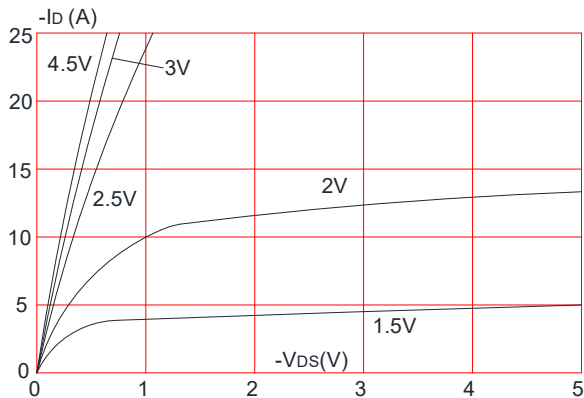


Figure 2: Typical Transfer Characteristics

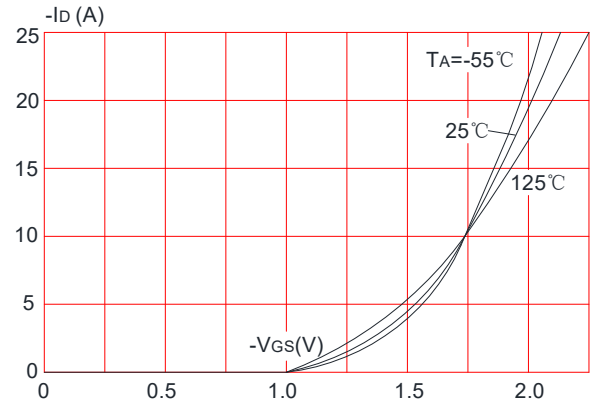


Figure 3: On-resistance vs. Drain Current

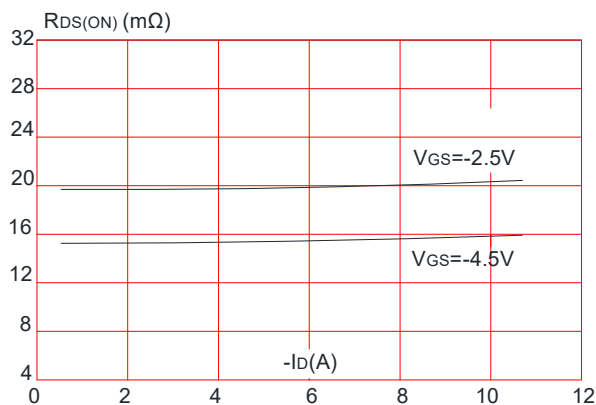


Figure 4: Body Diode Characteristics

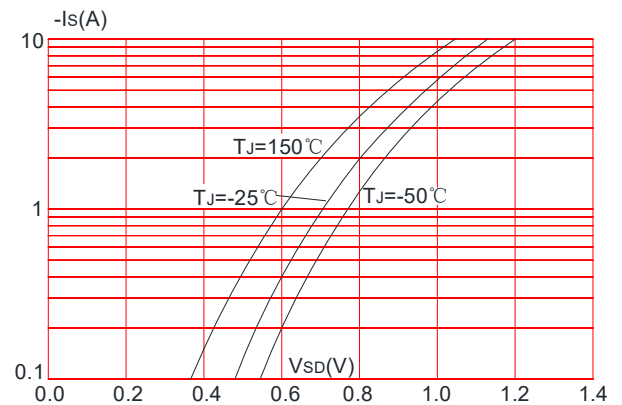


Figure 5: Gate Charge Characteristics

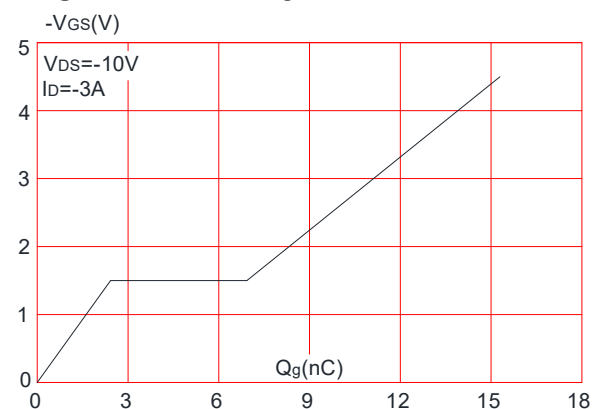
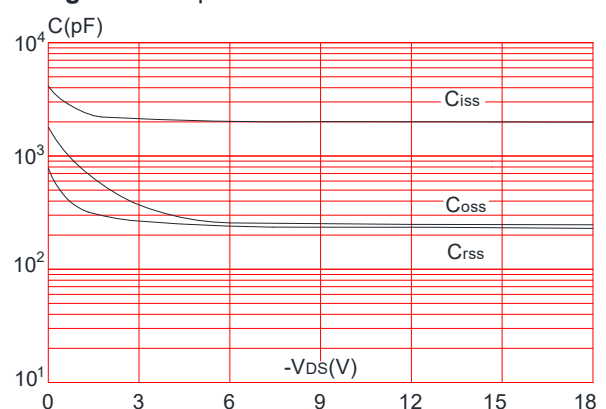


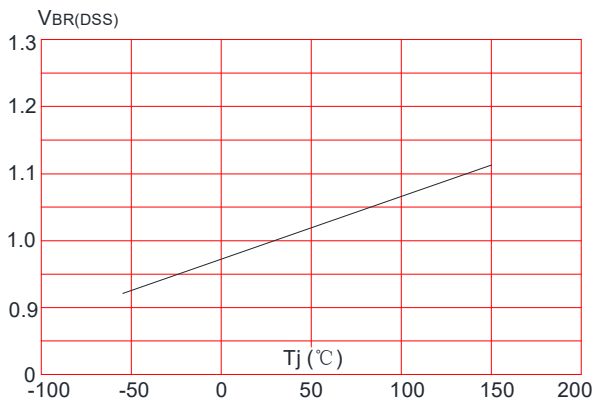
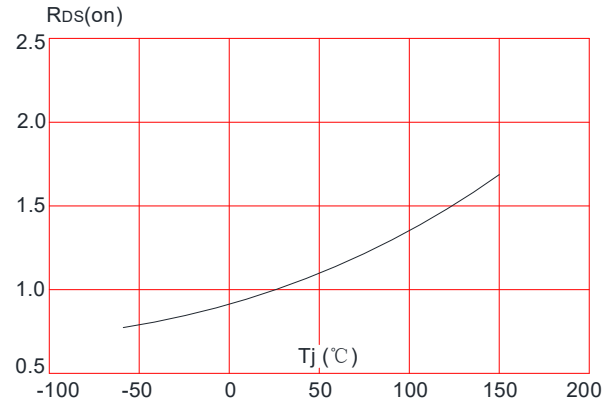
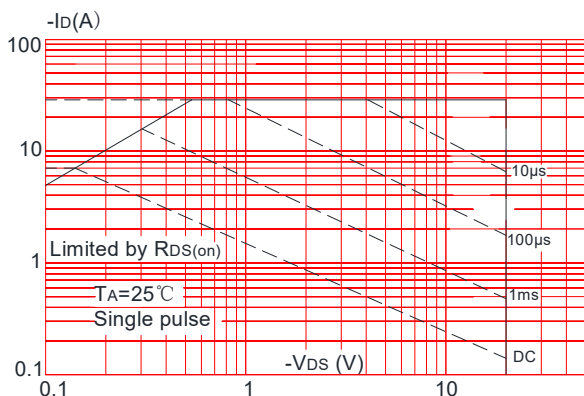
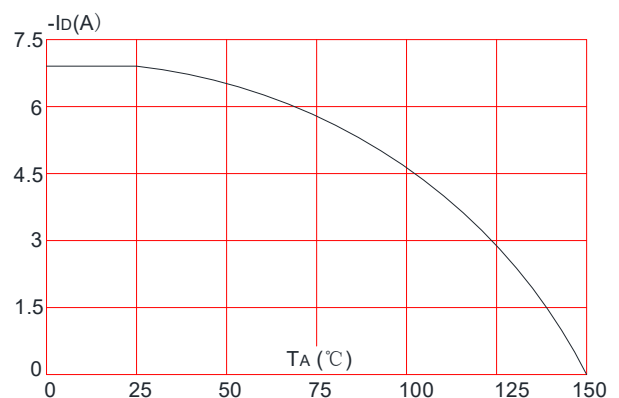
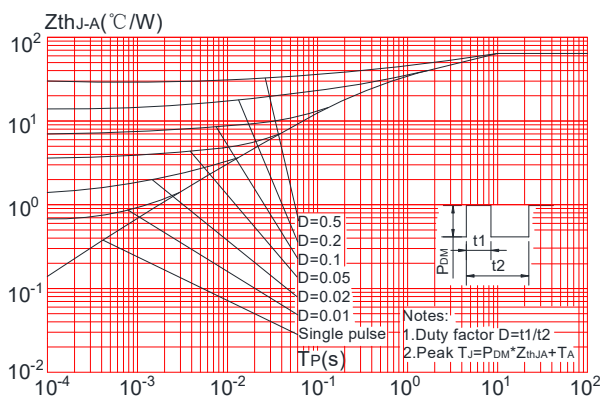
Figure 6: Capacitance Characteristics



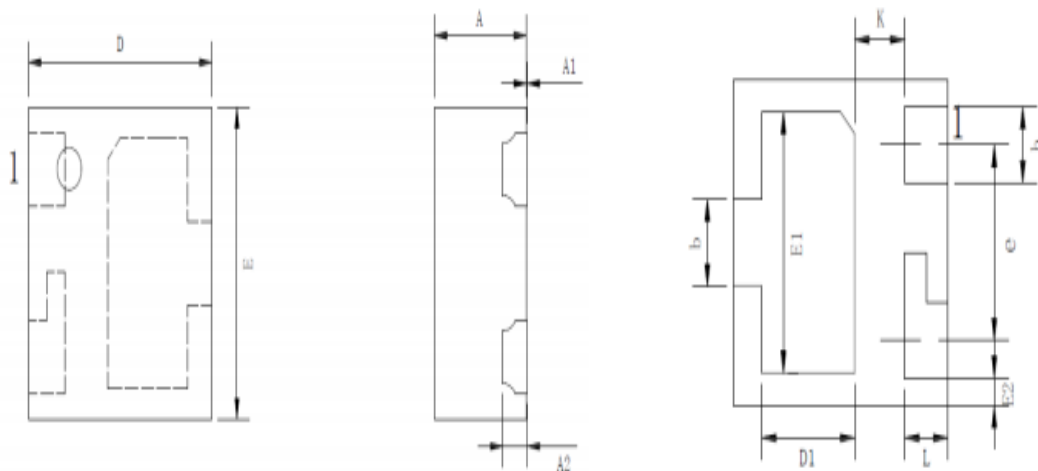


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Figure 7: Normalized Breakdown Voltage vs. Junction Temperature**Figure 8:** Normalized on Resistance vs. Junction Temperature**Figure 9:** Maximum Safe Operating Area**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature**Figure 11:** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

Package Information:DFN1.5x1.5-3L



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	—	—	0.80
A1	0.00	—	0.05
A2	0.203 TIY		
b	0.30	0.35	0.40
D	1.45	1.50	1.55
D1	0.60	0.65	0.70
E	1.45	1.50	1.55
E1	1.15	1.20	1.25
E2	0.125 TIY		
e	0.90 BSC		
K	0.35 BSC		
L	0.25	0.30	0.35